JUL 2 6 2002 33

SHEET 1 OF 1

Form PTO 1449		U.S. DEPARTMENT SPA	YOMMERCE .	ATTY DOCKET NO.		SERIAL NO.			
Form PTO 1449 U.S. DEPÁRTMENT EN DOMMERCE (Modified) PATENT AND TRADEMARK OFFICE			218210US0CONT	10/050,931					
				APPLICANT					
LIST OF REFERENCES CITED BY APPLICANT				Yoshiaki ł	II, et al.				
				FILING DATE		GROUP			
				January 22, 2002					
				U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS			
	AA								
	AB								
	AC	-							
	AD					1EDH/Y01027, 1000,			
	AE		•				- S - 7		
:	AF					1000		出册	
	AG						90	CEIVED	
	AH						C	N EN	
	Al						CENTER	ED	
	AJ						T.	2	
	AK							7	
	AL						ŏ		
	АМ								
	AN								
			FO	REIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES NO			
n	AO	JP6-231779	08/19/94	JAPAN (w/English Abstract)					
W	AP `	JP1-145729	06/07/89	JAPAN (w/English Abstract)					
w	AQ"	JP58-119348	07/15/83	JAPAN (w/English Abstract)				······································	
N	AR	JP58-201823	11/24/83	JAPAN (w/English Abstract)					
n	AS ⁶	EP 0 086 596	08/24/83	EUROPE		Х			
	ΑŤ								
	AU		.						
	AV			<u></u>					
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)									
		International Preliminary 6	xaminatio	n Report (Form PCT/IB/338)				•	
	AW								
	AX								
	AY								
	AZ				Addi	Additional References sheet(s) attached			
Examiner	1.0	40~			Date Considered 4 29 04				
*Examiner: in conformance	and no	efetence is considered, what considered. Include copy	ether or no of this form	t citation is in conformance with MPEP 60 n with next communication to applicant.	09; Draw li	ne through	citation	if not in	

Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCÉ PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. 218210US0CONT	SERIAL NO. NEW APPLICATION				
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yoshiaki HIGUCHI, et al.					
			FILING DATE HEREWITH	GROUP					
				U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS		IG DATE ROPRIATE	E
W	AA	6,087,032	07/11/00	YOSHITAKE, et al.					
	AB							4	
	AC							8	
	AD			·				200	
	AE							_\$	
	AF							5	
	AG							7	
	AH								
	Al								
-	AJ								
	AK			· · · · · · · · · · · · · · · · · · ·					
	AL								
	AM								
	AN			,					
			FO	REIGN PATENT DOCUMENTS		•			
		DOCUMENT NUMBER	DATE	COUNTRY		YES	TRANSLAT	TION NO	
W "	AO	WO01/06587 AI	01/25/01	WIPO (Abstract Only)					
	-AP	JP6-291779-	98/19/94	JAPAN				X	
W	AQ	JP11-45729	02/16/99	JAPAN				X	
	AD	JP58-110010	07/15/83	JAPAN				Х	
	-AG	JP59-201023	-11/24/83	JAPAN				х	
	-AT	EP-86506	08/24/83	EUROPE		×			
	AU								
	ΑV		_						
·····		OTHER REF	ERENCES (Including Author, Title, Date, Pertin	ent Pages, (etc.)			
	AW								
	AX								
	AY		,						
	ΑZ								
Examiner	1. (n			Date Cor		4/29/	OH	
Examiner: In	tial if re	eference is considered, w	hether or not	citation is in conformance with MPEP	609; Draw li	ine through	citation if n	ot in	